

# MOSFET - Power, Single N-Channel, DFN5/DFNW5 30 V, 4.8 mΩ, 55 A NVMFS4C308N

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- AEC-Q101 Qualified and PPAP Capable
- NVMFS4C308NWF Wettable Flanks Option for Enhanced Optical Inspection
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- Reverse Battery Protection
- DC-DC Converters Output Driver

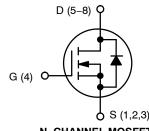
#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Volta	Gate-to-Source Voltage			±20	V
Continuous Drain		T <sub>A</sub> = 25°C		17.2	Α
Current R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C	I <sub>D</sub>	12.3	
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	3	W
Continuous Drain Current R <sub>0</sub> JC (Notes 1, 2, 3)	Steady State	T <sub>C</sub> = 25°C		55	
Continuous Drain Current R <sub>0</sub> JC (Notes 1, 2, 3)		T <sub>C</sub> = 100°C	Ι <sub>D</sub>	39	Α
Power Dissipation R <sub>θJC</sub> (Notes 1, 2, 3)		T <sub>C</sub> = 25°C	P <sub>D</sub>	30.6	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	144	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>STG</sub>	–55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	23	Α
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $V_{GS}$ = 10 V, $I_L$ = 29 $A_{pk}$ , $L$ = 0.1 mH, $R_{GS}$ = 25 $\Omega$ ) (Note 3)			E <sub>AS</sub>	42	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T <sub>L</sub>	260	°C	

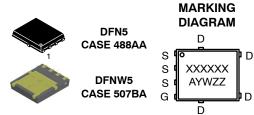
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum rating. Parts are 100% tested at  $T_J=25^{\circ}C$ ,  $V_{GS}=10$  V,  $I_L=21$  Apk,  $E_{AS}=22$  mJ.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30.\/	4.8 m $\Omega$ @ 10 V	55 A
30 V	7.0 mΩ @ 4.5 V	55 A



N-CHANNEL MOSFET



4C08N = Specific Device Code for NVMFS4C308N

4C08WF= Specific Device Code of NVMFS4C308NWF

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVMFS4C308NT1G	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS4C308NWFT1G	DFNW5 (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.9	°C/W
Junction-to-Ambient - Steady State	$R_{ heta JA}$	49.8	C/VV

# **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	$V_{GS}$ = 0 V, $I_{D(aval)}$ = 8.4 A, $T_{case}$ = 25°C, $t_{transient}$ = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				13.8		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 25°C				1.0	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	; = ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.3		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.9		mV/°0
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		4.0	4.8	<b>~</b> 0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		5.9	7.0	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			42		S
Gate Resistance	$R_{G}$	$T_A = 25^{\circ}$	C	0.3	1.0	2.0	Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1113	1670	
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH	Iz, V <sub>DS</sub> = 15 V		702		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				39		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 18	5 V, f = 1 MHz		0.035		
Total Gate Charge	Q <sub>G(TOT)</sub>				8.4		
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.8		]
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			3.5		nC
Gate-to-Drain Charge	$Q_{GD}$				3.3		
Gate Plateau Voltage	$V_{GP}$				3.4		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			18.2		nC
SWITCHING CHARACTERISTICS (Note 5)							-
Turn-On Delay Time	t <sub>d(ON)</sub>				9.0		
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{D}$	s = 15 V,		33		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			15		ns
Fall Time	t <sub>f</sub>				4.0		
Turn-On Delay Time	t <sub>d(ON)</sub>				7.0		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	s = 15 V.		26		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	I <sub>D</sub> = 15 A, R <sub>G</sub>	= 3.0 Ω		19		ns
Fall Time	t <sub>f</sub>				3.0		1

- 4. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 5. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	T <sub>J</sub> = 25°C		0.79	1.1	V
		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.66		V
Reverse Recovery Time	t <sub>RR</sub>		•		28.3		
Charge Time	t <sub>a</sub>	$V_{GS}$ = 0 V, dIS/dt = 100 A/ $\mu$ s, $I_S$ = 30 A			14.5		ns
Discharge Time	t <sub>b</sub>				13.8		
Reverse Recovery Charge	$Q_{RR}$	1			15.3		пC

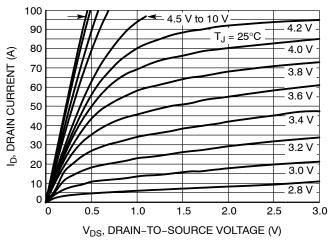
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>4.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

80

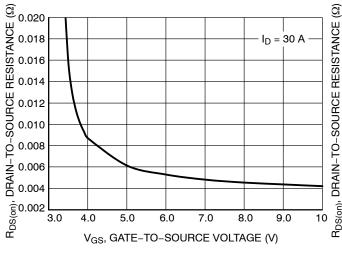
 $V_{DS} = 3 V$ 



70 ID, DRAIN CURRENT (A) 60 50 40 30  $T_J = 125^{\circ}C$ 20  $T_J = 25^{\circ}C$ 10  $T_{.1} = -55^{\circ}C$ 0 0.5 2.0 2.5 3.0 3.5 4.0 1.0 1.5 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



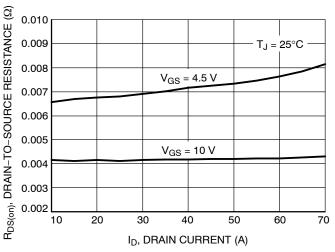
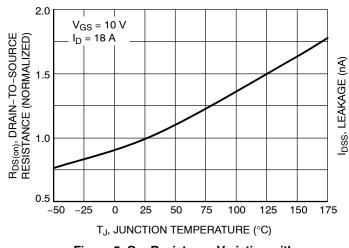


Figure 3. On-Resistance vs. V<sub>GS</sub>

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



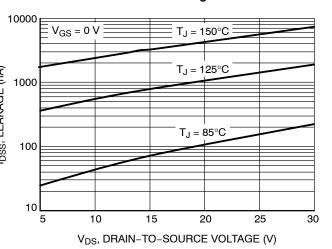


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

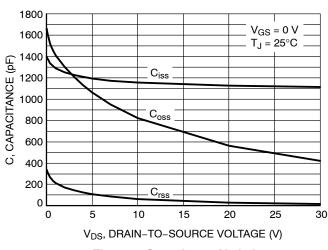


Figure 7. Capacitance Variation

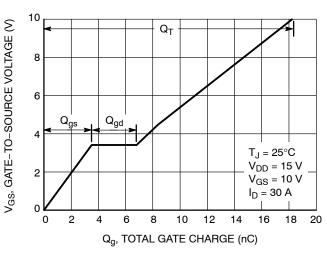


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

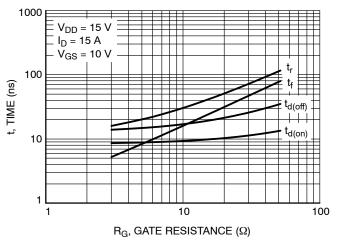


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

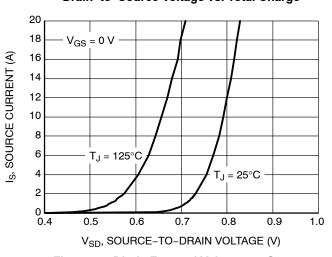


Figure 10. Diode Forward Voltage vs. Current

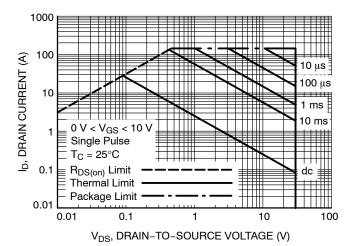


Figure 11. Maximum Rated Forward Biased Safe Operating Area

#### **TYPICAL CHARACTERISTICS**

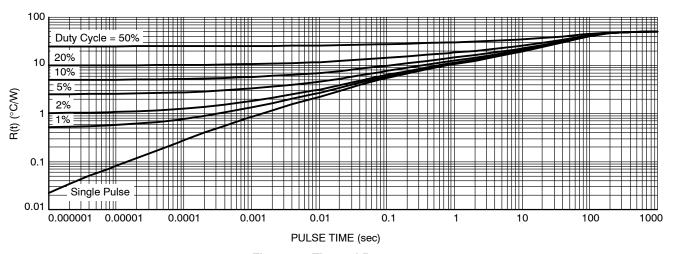


Figure 12. Thermal Response

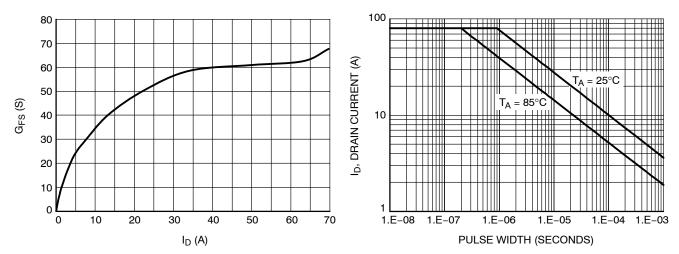


Figure 13. G<sub>FS</sub> vs. I<sub>D</sub>

Figure 14. Avalanche Characteristics

2 X





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC			
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	(	0.125 RE	F		
М	3.00	3.40	3.80		
θ	0 °		12 °		

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

= Lot Traceability

= Assembly Location Α

Υ = Year W = Work Week

ZZ

3.200

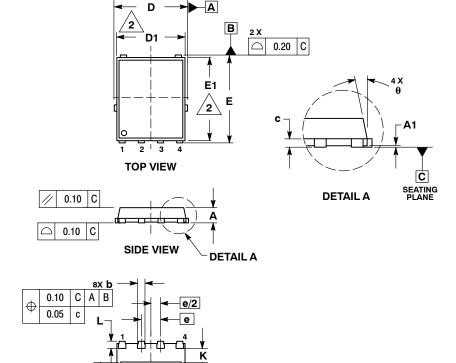
1.330

1.270 **PITCH** 

**DIMENSIONS: MILLIMETERS** 

4.530

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.



2X

0.495

2X

0.475

2X 0.905

**A** 

0.965

1.000

4X 0.750 →

0.20 C

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

RECOMMENDED

**SOLDERING FOOTPRINT\*** 

2X

1.530

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**E2** 

D2

**BOTTOM VIEW** 

STYLE 2:

PIN 1. ANODE 2. ANODE 3. ANODE 4. NO CONNECT

5. CATHODE

G

PIN 5

(EXPOSED PAD)

STYLE 1:

PIN 1. SOURCE 2. SOURCE 3. SOURCE

4. GATE

5. DRAIN

**IDENTIFIER** 

// 0.10 C

○ 0.10 C



# DFNW5 5x6 (FULL-CUT SO8FL WF)

CASE 507BA **ISSUE A** 



**MILLIMETERS** 



TES:

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.

CONTROLLING DIMENSION: MILLIMETERS

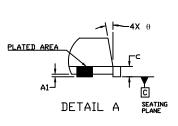
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,

PROTRUSIONS, OR GATE BURRS.

THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN

FEATURES TO AID IN FILLET FORMATION ON THE LEADS

DURING MOUNTING.



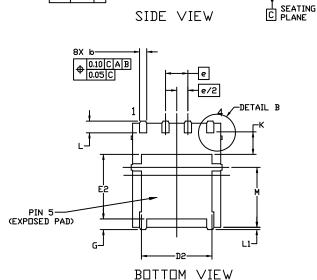
DIM	MIN.	N□M.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
c	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
Ε	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
e	1.27 BSC			
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	

0.150 REF

3.40

3.80

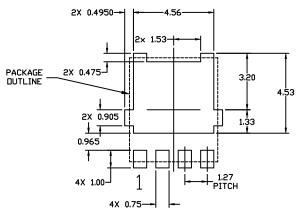
12\*



TOP VIEW

DETAIL A





L1

М

θ

3.00

0°

# RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the  $\square N$ Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

#### **GENERIC** MARKING DIAGRAM\*



XXXXXX = Specific Device Code \*This information is generic. Please refer to

= Lot Traceability

= Assembly Location Α

Υ = Year W = Work Week

77

device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products

may not follow the Generic Marking.

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